

# DEVELOPMENT OF A 1 kW, 200°C MAPHAM INVERTER UTILIZING HIGH TEMPERATURE COMPONENTS

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## ABSTRACT

Electronic systems and components are often exposed to high temperature environment in space-based applications, nuclear power facilities, and geothermal energy extraction fields. A key requirement for these systems is, therefore, to withstand the high temperature exposure while maintaining efficient and reliable operation. Efforts were taken to design and develop a high temperature power inverter capable of 200°C operation. In this work, a 1 kW, 20 kHz Mapham inverter was designed and built utilizing components developed for high temperature operation. These components, which included capacitors, inductors, transformers, were developed and demonstrated at 200°C. The inverter system was evaluated as a function of temperature at different load levels. The inverter system, excluding its input, control and logic circuitries, was characterized at temperatures from ambient to 200°C at 0%, 50%, and 100% resistive loading. With an applied input voltage of 75 VDC, the inverter produced an output of 250 VAC. The results obtained, which have indicated good operational characteristics of the inverter up to 200°C, are presented and discussed.

## INTRODUCTION

Future challenges of advanced power systems comprise increasing packaging density, improving reliability, and surviving hostile environment. High temperature constitutes one of the harsh stresses where power systems and

components will be exposed to during their lifetime. These applications include deep space exploration, communications satellites, and supersonic transport vehicles. Others include engine and brake-mounted sensors and electronics in the auto industry, and control and instrumentation in well logging fields. For space-based applications, there is an enormous demand for increasing the energy densities and raising the power levels of the power systems and associated components with the objectives to reduce size and weight, and to further improve efficiency and reliability. These requirements, however, will certainly result in raising the operating temperature of the power system and will create, among other things, thermal stresses that well exceed the withstanding or normal operating level of the presently available devices and components. Improvement in the current designs and processes, and the identification of new materials and components capable of providing reliable and efficient operation at high temperature, thus, play important role for future needs of space power systems to be met. In addition to meeting the requirements of hostile environment survivability and endurance, other benefits that can be gained from the availability of reliable components and systems with high temperature capability include reduced launch cost, simplified system design, and improved thermal management. It has been reported, for example, that high temperature components can make a significant improvement in reliability for

satellite missions on the order of a hundred years [1].

A program to develop lightweight, reliable 200°C power inverter for aerospace applications is being performed at NASA Lewis Research Center. As part of this effort, an existing 1 kW Mapham inverter designed to operate at room temperature was modified to investigate potential 200°C operation. Modification of the system included circuit design and the utilization of in-house developed high temperature components. The inverter was characterized at high temperature from ambient to 200°C at 0%, 50%, and 100% resistive loading. In this paper, the experimental procedure and the results obtained are discussed.

#### EXPERIMENTAL PROCEDURE

As was mentioned earlier, an existing power inverter designed for room temperature operation was modified in order to explore high temperature capability. The original inverter is generally known as a Mapham inverter capable of providing 1 kW with a 125 VDC input. It uses a resonant tank circuit in an H-bridge configuration to develop a sinusoidal voltage across the resonant capacitor with a fundamental output frequency of 20 kHz [2]. Modification of the inverter included circuit reconfiguration and utilization of high temperature power components that were developed either in-house or through collaborative research efforts [3-5]. The basic circuit diagram of the inverter is shown in Figure 1 with the dashed block representing the section which was exposed and thus evaluated at high temperatures. A list of the high temperature components used is given in Table 1 [3-5].

Evaluation of the inverter was performed at high temperature with various load levels. A bias of 75 VDC was supplied to the input stage of the inverter which resulted in an output voltage of 250 VAC at about 20 kHz. A Hewlett-Packard Model 4030A power supply was used for the input while Systron Donner TL8-3 furnished power for the control logic. A Hotpack oven was used as the heating chamber and thermocouples were mounted on the individual switches, inductors, capacitors, and on the center and end

of the coaxial transformer using a Duralco 4525 epoxy. The temperatures of the chamber and the components were monitored by a Keithley 740 System Scanning Thermometer and a Doric Trendicator. At a given load level, the inverter circuit was characterized as a function of temperature from ambient to 200°C in 25°C increments. A soak period of 30 minutes was allowed at each test temperature to allow thermal stabilization. The temperature rise and variations of the various components were recorded. In addition, the values and the waveforms of many monitored signals were obtained using Tektronix DSA 602A Waveform Analyzer. The measured signals included the voltages and currents of the input source, switches, inductors, capacitors, and the transformer primary and secondary windings. Besides the high temperature characterization, the effect of loading on the measured properties was also determined as the inverter was subjected to 0% (open-circuit secondary), 50% (145  $\Omega$ ), and 100% (72  $\Omega$ ) resistive loading at a given test temperature.

#### RESULTS AND DISCUSSIONS

The operational characteristics of the inverter were investigated by monitoring and recording the temperature variation of the inverter components as well as the current and voltage levels and waveforms of several variables. During the course of testing, however, there was little deviation in the operation of the inverter and insignificant change in many of its measured parameters whether by applying different test temperature or changing the load level. Therefore, only selected data will be presented.

The switch and output capacitor current and voltage waveforms with no load applied at 25°C and 200°C are shown in Figures 2 and 3, respectively. These waveforms are also shown in Figures 4 and 5 with 100% resistive load connected to the inverter output. It can be clearly seen that no major variations were exhibited by these parameters due to change in test temperature or load level. For both no load and full load conditions, it should be pointed out,

however, that slight increase in the switch (IGBT-diode) voltage turn-off overshoot occurs as the test temperature was increased to 200°C. It is believed that this overshoot is most likely due to the increase in diode reverse recovery time with temperature [5]. Initially, 150°C rated diodes were used but they failed to operate for any significant time at 200°C. These diodes were then replaced by 175°C rated units and, as a result, extended operation at 200°C was achieved.

Figure 6 depicts the difference between the case temperature of one of the inductors and that of the chamber as a function of chamber temperature for three load levels. At a given test temperature, the inductor case temperature had an average of 20° AT higher than that of the test chamber.

Similar trend was observed for all inductors. Unlike the inductors, the AT in the case temperature of the switches amounted only to about 15°C, as shown in Figure 7. It is important to note that the higher AT experienced by the inductors was due to the fact that the thermocouple mounted on the inductor winding was wrapped with Teflon tape for mechanical support. This insulation layer might have affected thermal distribution and interfacial equilibrium.

### CONCLUSIONS

Key design requirements for advanced space-based power systems include higher energy densities, larger power levels, and better harsh environment survivability. The development of high temperature components is therefore necessary to meet these goals and to further improve on the mission's thermal management design, durability and cost effectiveness. In this work, a 1 kW Mapham inverter utilizing some high temperature components as its output and switching stages was evaluated at three load levels in the temperature range of room to 200°C. The preliminary results indicate that the power inverter operated successfully over the entire temperature range and at various load levels without any noticeable change in its characteristic behavior. In fact, the inverter showed good stability in its

overall performance although some of the individual components exhibited slight variation in their properties with temperature. Although the present work demonstrated 200°C operation of the power inverter, more testing is required to fully characterize the reliability of the system and to determine its potential for long term use in high temperature environments.

### ACKNOWLEDGEMENTS

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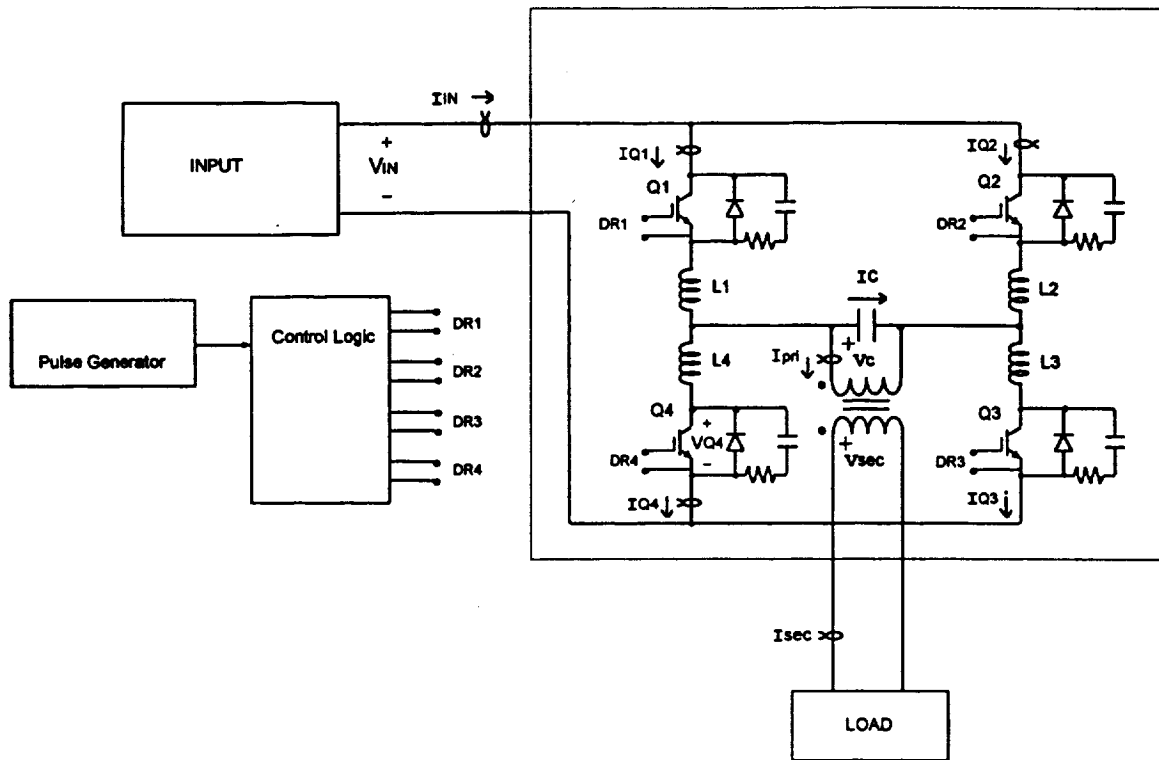


Figure 1. Basic circuit of the Mapham Inverter

Table 1. High Temperature Components Specifications [3-5].	
Component	Specification
Capacitor	Capacitance: 1.0 uF Voltage: 125 VAC Frequency: 20 kHz Dielectric: film
Inductor	Inductance: 13 uH Core: MPP Frequency: 20 kHz Current: 25 A
Transformer	Power: 2.5 kVA Voltage: 125/250 VAC Frequency: 20 kHz Core: 80% Nickel tape
Switch	Device: IGBT TA9796 Voltage: 1000 V Current: 34 A

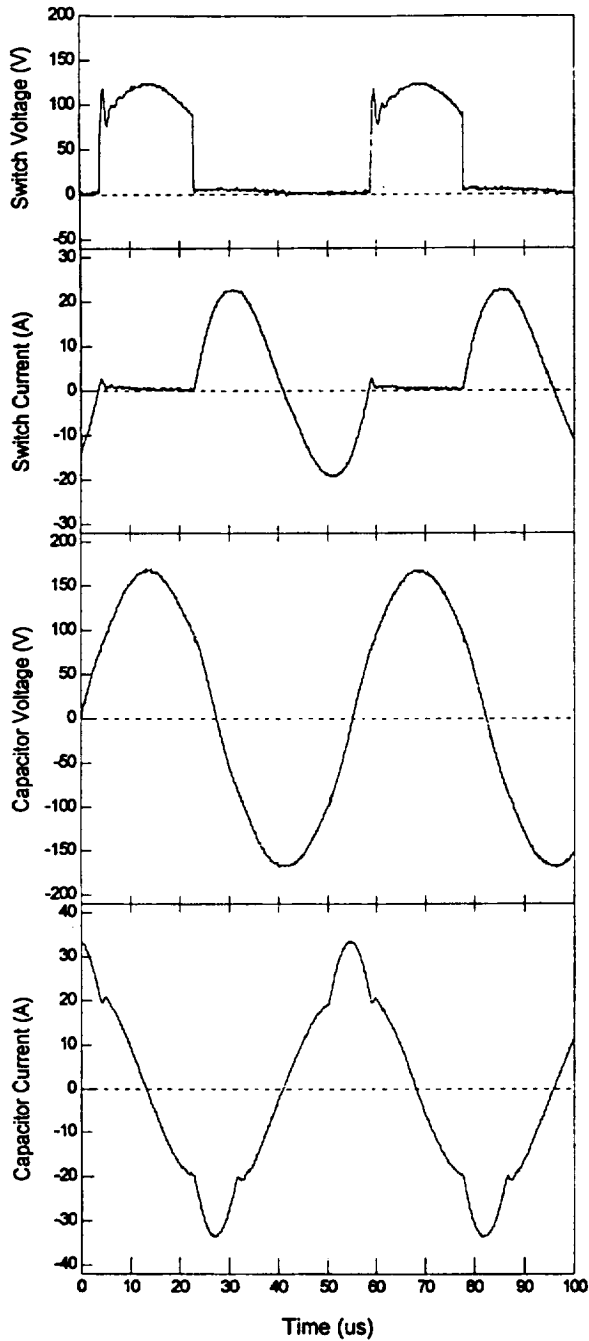


Figure 2: Switch (Q4) and output capacitor currents and voltages with no load at 25°C.

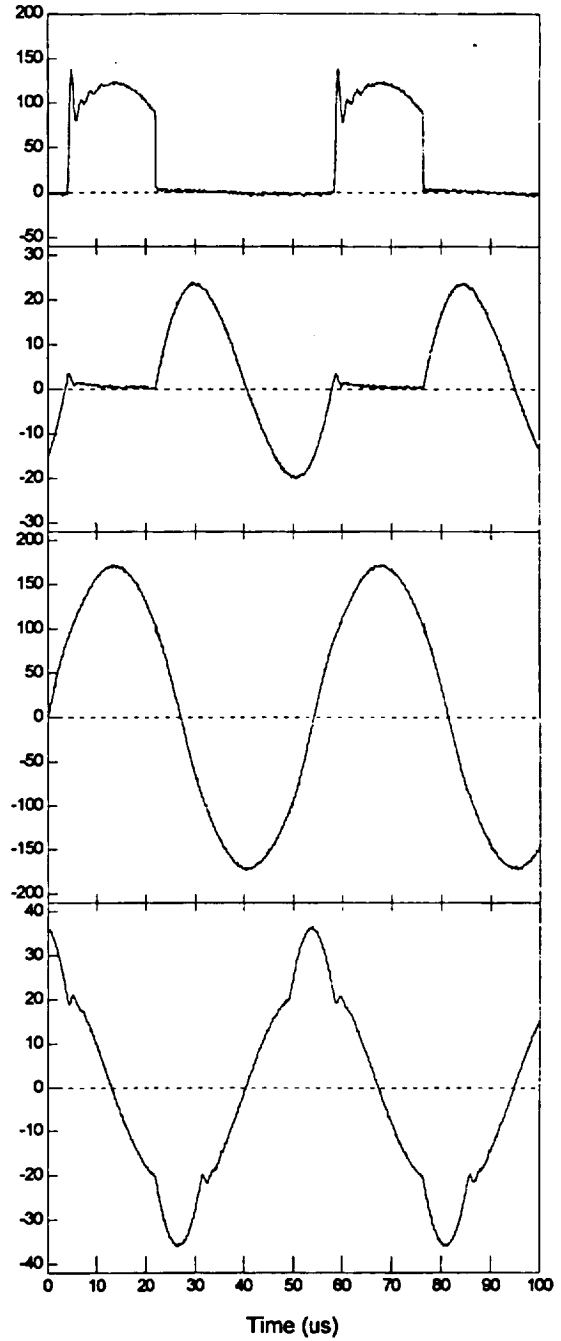


Figure 3: Switch (Q4) and output capacitor currents and voltages with no load at 200°C.

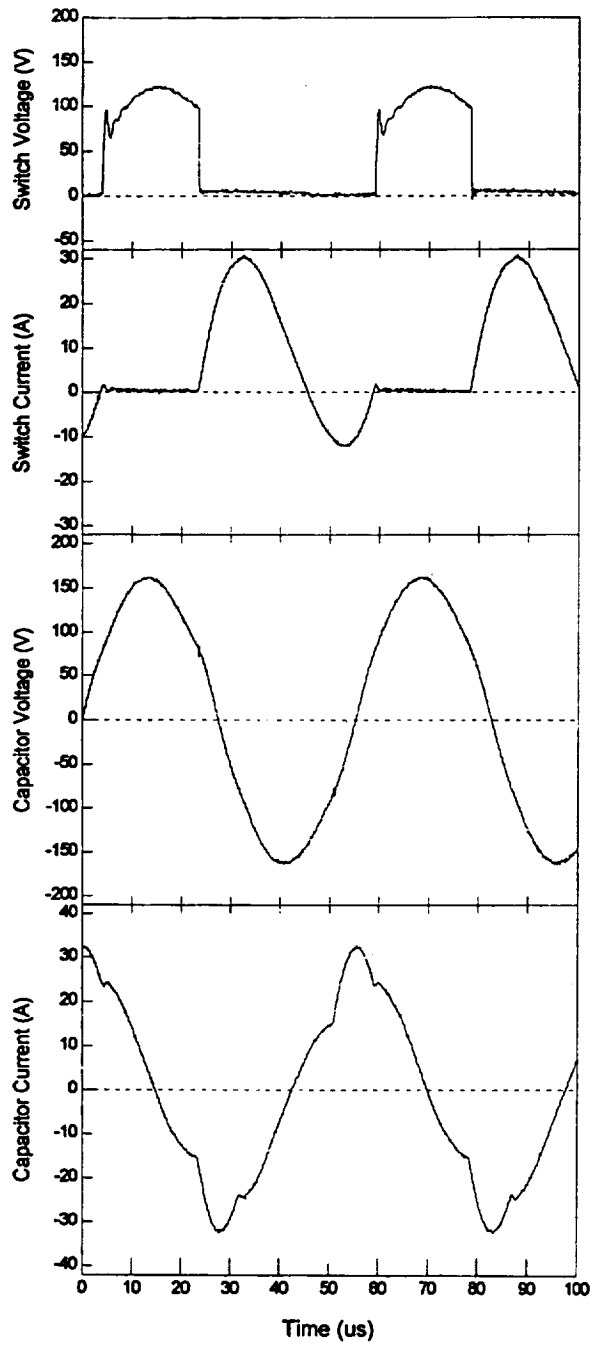


Figure 4: Switch (Q4) and output capacitor currents and voltages with full load at 25°C.

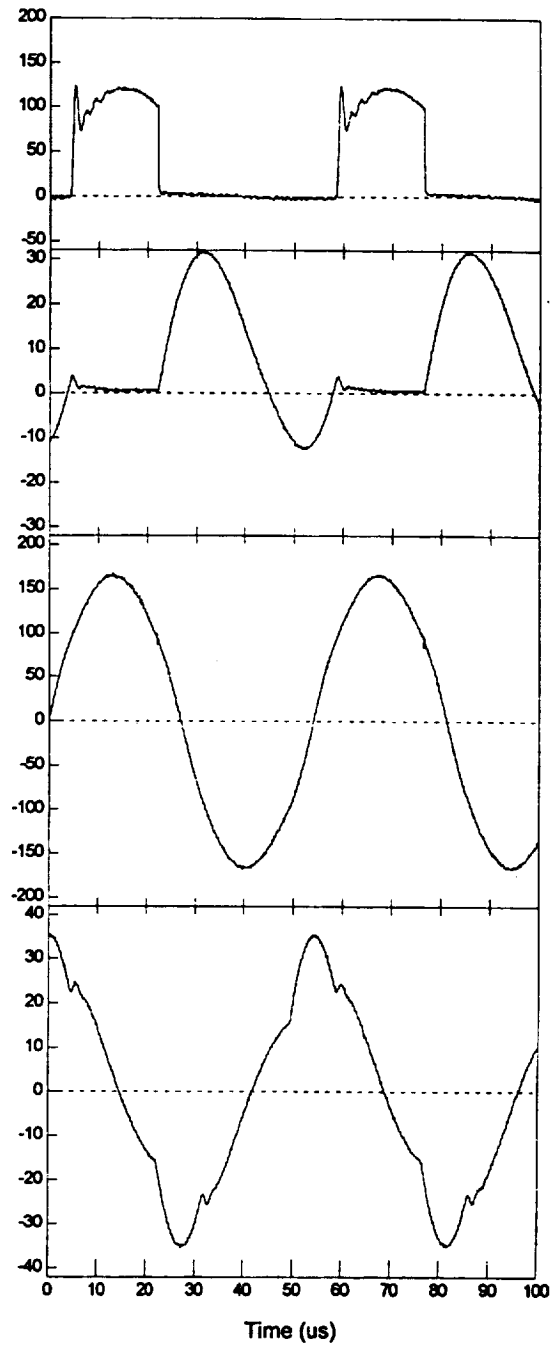


Figure 5: Switch (Q4) and output capacitor currents and voltages with full load at 200°C.

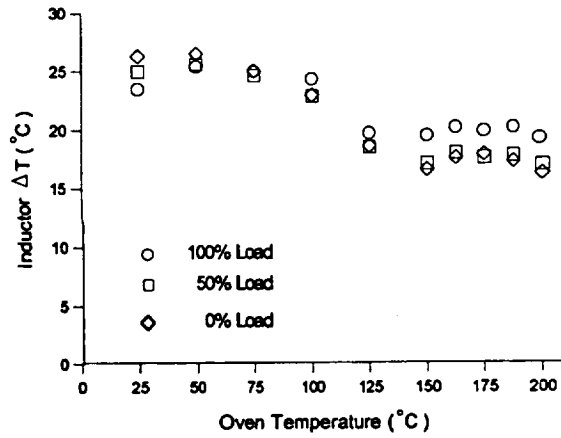


Figure 6: Inductor temperature rise above that of the chamber at various loads.

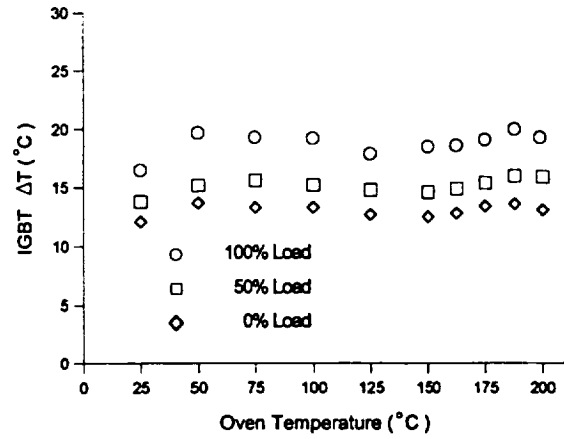


Figure 7: Switch temperature rise above that of the chamber at various loads.

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